Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/796,094	TAKE, KEIJIRO
Examiner	Art Unit
Tri H. Phan	2661

SEARCHED					
Class	Subclass	Date	Examiner		
370	320,335, 342,441, 479,203	12/3/2004	TP		
370	350,332	12/3/2004	TP		
370	508-510	12/3/2004	TP		
375	200	12/3/2004	TP		
Updated	search	6/20/2005	TP		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, IEEE, Internet searched	12/3/2004	TP		
Updated search	6/20/2005	ТР		